

<b>Notice of References Cited</b>	Application/Control No. 10/697,471	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,069,620	05-2000	Nakamura et al.	345/214
*	B	US-6,121,945	09-2000	Tanaka et al.	345/94
*	C	US-6,933,916	08-2005	Nakao et al.	345/98
*	D	US-2003/0169234	09-2003	Kempisty, Mark S.	345/158
*	E	US-7,023,416	04-2006	Nakamura et al.	345/99
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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